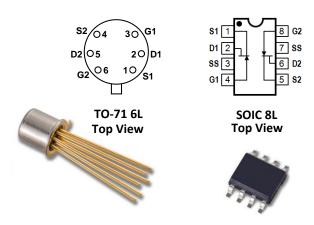
| Absolute Maximum Ratings | | | | | |
|--|-------------------|--|--|--|--|
| @ 25 °C (unless otherwise stated) | | | | | |
| Maximum Temperatures | | | | | |
| Storage Temperature | -65 to +150°C | | | | |
| Junction Operating Temperature | -55 to +135°C | | | | |
| Maximum Power Dissipation | | | | | |
| Continuous Power Dissipation @ +25°C 400mW | | | | | |
| Maximum Currents | | | | | |
| Gate Forward Current | $I_{G(F)} = 10mA$ | | | | |
| Maximum Voltages | | | | | |
| Gate to Source | $V_{GSS} = 40V$ | | | | |
| Gate to Drain | $V_{GDS} = 40V$ | | | | |



Features

- Ultra Low Noise: e_n = 1.9nV/√Hz (typ), f = 1kHz and NBW = 1Hz
- Tight Matching: IV_{GS1-2}I = 20mV max
- High Breakdown Voltage: BV_{GSS} = 40V max
- High Gain: Gfs = 20mS (typ)
- Low Capacitance: 25pF typ
- Improved Second Source Replacement for 2SK389

Benefits

- Unique Monolithic Dual Design Construction of Interleaving Both JFETs on the Same Piece of Silicon
- Excellent Matching and Thermal Tracking
- Great for Maximizing Battery Operated Applications by Providing a Wide Output Swing
- A High Signal to Noise Ratio as a Result of the LSK389's Low and Tightly Matched Gate Threshold Voltages

Applications

- · Audio Amplifiers and Preamps
- Discrete Low-Noise Operational Amplifiers
- Battery-Operated Audio Preamps
- Audio Mixer Consoles
- Acoustic Sensors
- Sonic Imaging
- Instrumentation Amplifiers Microphones
- Sonobouys
- Hydrophones
- · Chemical and Radiation Detectors

Description

The LSK389 Series, Monolithic Dual N-Channel JFETs were specifically designed to provide users a better performing, less time consuming and cheaper solution for obtaining tighter IDSS matching, and better thermal tracking, than matching individual JFETs. The LSK389's features incorporate four grades of IDSS: 2.6-6.5mA, 6.0-12.0mA, 10.0-20.0mA and 17-30mA, with an IDSS match of 10 percent, a gate threshold offset of 20mV, a voltage noise (en) of 1.9nV/√Hz typical, with a Gain of 20mS typical, and 25pF of capacitance typical. The LSK389 provides a wide output swing, and a high signal to noise ratio as a result of the LSK389's tightly matched and low gate threshold voltages.

The 40V breakdown provides maximum linear headroom in high transient program content amplifiers.

Additionally, the LSK389 provides a low input noise to capacitance product that has nearly zero popcorn noise. The narrow ranges of the IDSS electrical grades combined with the superior matching performance of the LSK389's monolithic dual construction promote ease of device tolerance in low voltage applications, as compared to matching single JFETs. Available in surface mount SOIC 8L and thru-hole TO-71 6L packages.

Matching Characteristics @ 25°C (unless otherwise stated)

| SYMBOL | CHARACTERISTIC | MIN | TYP | MAX | UNITS | CONDITIONS |
|-----------------------------------|--|-----|-----|-----|---------|------------------------------|
| $V_{\text{GS1}} - V_{\text{GS2}}$ | Differential Gate to Source Cutoff Voltage | | | 20 | ^{m}V | $V_{DS} = 10V$, $I_D = 1mA$ |
| IDSS1 IDSS2 | Saturation Drain Current Ratio | 0.9 | 1.0 | 1.1 | n/a | $V_{DS} = 10V, V_{GS} = 0V$ |

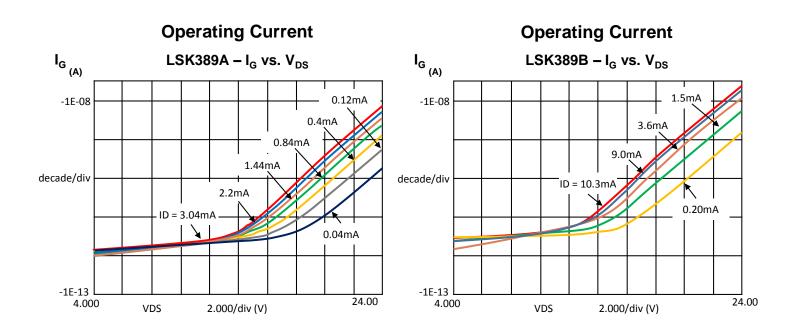
Electrical Characteristics @ 25°C (unless otherwise stated)

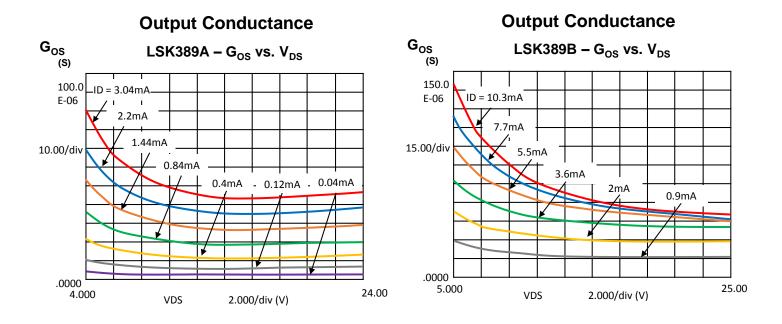
| SYMBOL | CHARACTERISTIC | | MIN | TYP | MAX | UNITS | CONDITIONS |
|----------------------|---------------------------------------|---------|-------|-----|------|--------|---|
| BV _{GSS} | Gate to Source Breakdown Voltage | | -40 | | | V | $V_{DS} = 0$, $I_D = -100\mu A$ |
| V _{GS(OFF)} | Gate to Source Pinch-off Voltage | | -0.15 | | -2 | V | $V_{DS} = 10V, I_D = 0.1 \mu A$ |
| I _{DSS} | Drain to Source Saturation Current | LSK389A | 2.6 | | 6.5 | mA | $V_{DS} = 10V, V_{GS} = 0$ |
| | | LSK389B | 6 | | 12 | | |
| | | LSK389C | 10 | | 20 | | |
| | | LSK389D | 17 | | 30 | | |
| I _{GSS} | Gate to Source Leakage Current | | | | -200 | pА | $V_{GS} = -30V, V_{DS} = 0$ |
| I _{G1G2} | Gate to Gate Isolation Current | | | | ±1.0 | μΑ | $V_{G1^-G2} = \pm 45V$, $I_D = I_S = 0A$ |
| G_fs | Full Conduction Transconductance | | 8 | 20 | | mS | $V_{DS} = 10V, V_{GS} = 0, f = 1kHz$ |
| e _n | Noise Voltage | | | 1.9 | | nV/√Hz | $V_{DS} = 10V$, $I_D = 2mA$, $f = 1kHz$, NBW = 1Hz |
| e _n | Noise Voltage | | | 4.0 | | nV/√Hz | $V_{DS} = 10V$, $I_{D} = 2mA$, $f = 10Hz$, $NBW = 1Hz$ |
| C _{ISS} | Common Source Input Capacitance | | | 25 | | pF | $V_{DS} = 10V, V_{GS} = 0, f = 1MHz,$ |
| C _{RSS} | Common Source Reverse Transfer Cap. | | | 5.5 | | pF | $V_{DG} = 10V$, $I_D = 0$, $f = 1MHz$, |

Notes

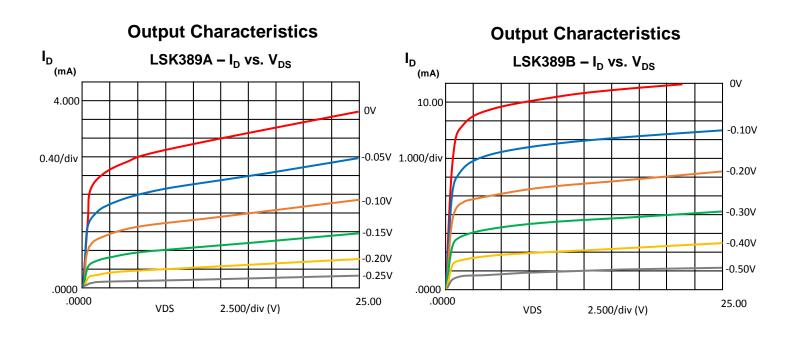
- 1. The noise spec is guaranteed by design.
- 2. Absolute maximum ratings are limiting values above which serviceability may be impaired.
- 3. Pulse Test: PW ≤ 300µs, Duty Cycle ≤ 3%
- 4. All characteristics MIN/TYP/MAX numbers are absolute values. Negative values indicate electrical polarity only. Information furnished by Linear Integrated Systems is believed to be accurate and reliable. However, no responsibility is assumed for its use; nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Linear Integrated Systems.

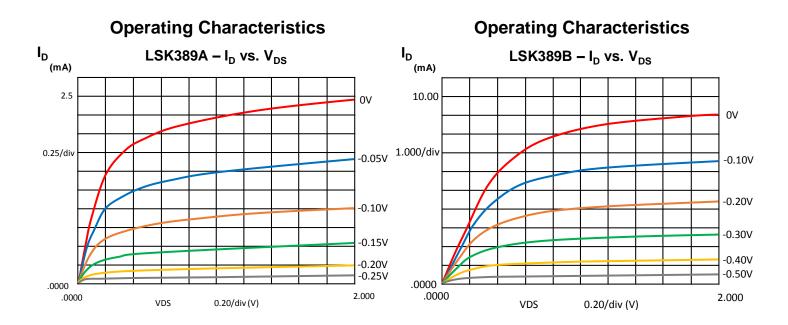
Typical Characteristics



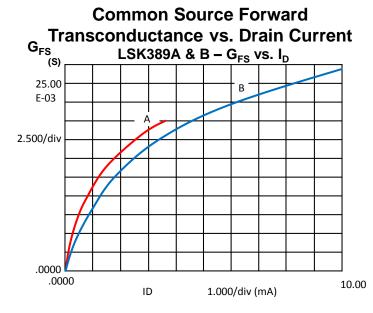


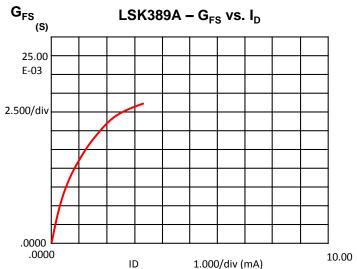
Typical Characteristics



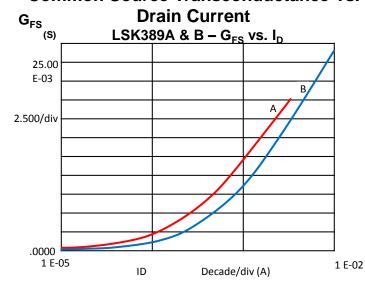


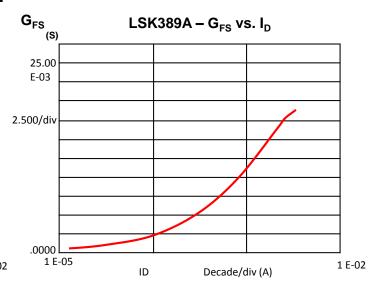
Typical Characteristics



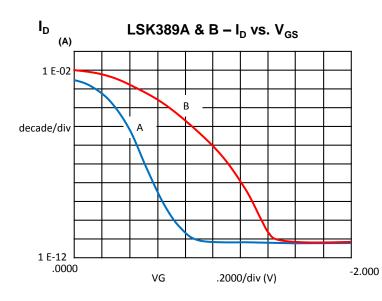


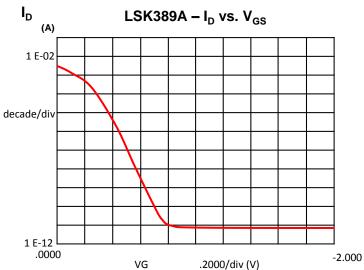
Common Source Transconductance vs.

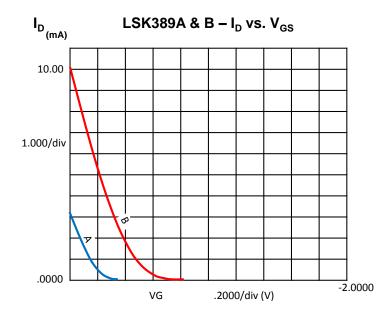


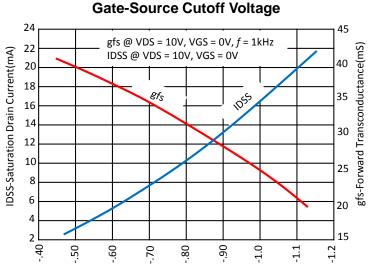


Typical Characteristics





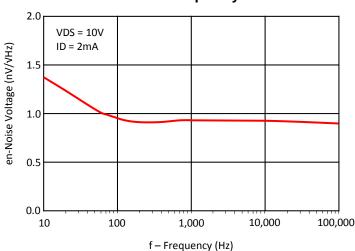




Drain Current Transconductance vs.

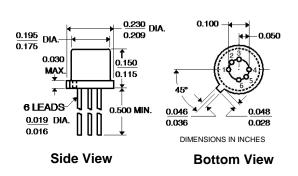
Typical Characteristics

Equivalent Input Noise Voltage vs. Frequency

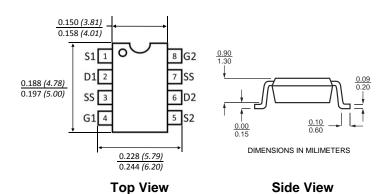


Package Dimensions

TO-71 6 Lead



SOIC 8 Lead



SS: Substrate, Leave These Pins Floating (N/C)

Ordering Information LSK389XY

| Χ | IDSS Range (mA) |
|---|-----------------|
| Α | 2.6 to 6.5 |
| В | 6.0 to 12.0 |
| С | 10.0 to 20.0 |
| D | 17.0 to 30.0 |

| Υ | Package |
|---|----------|
| Т | TO-71 6L |
| S | SOIC-8L |

A Typical Order: LSK389BT (This is B grade packaged into a TO-71 6L package.)